

Notice of References Cited	Application/Control No. 10/674,418		Applicant(s)/Patent Under Reexamination YAMAKAWA ET AL.	
	Examiner Jean W. Désir		Art Unit 2622	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,724,398 B2	04-2004	Someya et al.	345/690
*	C	US-5,844,533 A	12-1998	Usui et al.	345/89
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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